## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/524,100	inventRAMIREZ, STEVEN W	
Examiner	Art Unit	

Trinh T. Nguyen

SEARCHED					
Class	Subclass	Date	Examiner		
47	39,41.01 41.1,41.11 41.12 41.13	6/5/2008	TTN		
	41.14				
	41.15				
D11	146 147				
248	27.8 309.4				
	175				
D6	556				
24	5,303				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
		1 -1		
	T 1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor name search was performed.	6/5/2008	TTN		